

INFORMATION DISCLOSURE (Use several sheets if necessary)			ATTY DOCKET NO.	APPLICATION NO.		
			17076	10/672,550		
			APPLICANT(S)			
			Kaoru Uchida			
			FILING DATE	GROUP ART UNIT		
			9/26/03	2621		
PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AL	4,225,850	Chang et al.				
U.S. PATENT APPLICATION PUBLICATIONS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						YES
AL	DE19929671A1	1/11/01	GERMANY			NO
	DE4220971A1	1/7/93	GERMANY			
	EP 0 736836 A2	10/9/96	EPO			
	WO 01/24700 A1	4/12/01	PCT			
↓	4-33065	2/4/92	JAPAN			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
AL		D. M. Weber, "A Cost Effective Fingerprint Verification Algorithm for Commercial Applications", Communications and Signal Processing, 1992, Comsig '92, Proceedings of the 1992 South African Symposium on Cape Town, South Africa, September 11, 1992, IEEE, pp 99-104				
EXAMINER /Alex Kok Liew/ (01/05/2007)			DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	ATTY DOCKET NO. 17076	APPLICATION NO. 10/672,550
	Kaoru Uchida	
	FILING 9/26/03	GROUP ART 2621

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
AL		3150126	1/19/01	JAPAN				
		8-110949	4/30/96	JAPAN				
		8-161491	6/21/96	JAPAN				
		9-274656	10/21/97	JAPAN				
▼		2001-266133	9/28/01	JAPAN				

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

EXAMINER /Alex Kok Liew/ (01/19/2007)

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
AL		56-24675	3/9/81	JAPAN			
AL		2776757	5/1/98	JAPAN			

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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INFORMATION BY CLOSURE CITATION

(Use several sheets if necessary)

APR 03 2006

Docket Number (Optional)

17076

Application Number

10/672,550

Applicant(s)

Kaoru Uchida

Filing Date

September 26, 2003

Group Art Unit

2624

U.S. PATENT DOCUMENTS

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U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
AL		H10-177650	6/30/98	Japan				✓
AL		H08-129644	5/21/96	Japan				✓
AL		2002-133417	5/10/02	Japan				✓

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

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